onsemi

MOSFET – Single N-Channel, POWERTRENCH[®]

60 V, 7.5 A, 23 m Ω

FDMA86551L

General Description

This device has been designed to provide maximum efficiency and thermal performance for synchronous buck converters. The low $R_{DS(on)}$ and gate charge provide excellent switching performance.

Features

- Max $R_{DS(on)} = 23 \text{ m}\Omega @ V_{GS} = 10 \text{ V}, I_D = 7.5 \text{ A}$
- Max $R_{DS(on)} = 35 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}, I_D = 6 \text{ A}$
- Low Profile 0.8 mm Maximum in the New Package MicroFET[™] 2x2 mm
- This Device is Pb-Free, Halide Free and RoHS Compliant

Applications

• DC–DC Buck Converters

ABSOLUTE MAXIMUM RATINGS (T_A = 25° C unless otherwise noted)

-		
Parameter	Value	Unit
Drain to Source Voltage	60	V
Gate to Source Voltage	±20	V
Drain Current – Continuous (Note 1a) T _A = 25°C – Pulsed (Note 4)	7.5 45	A
Single Pulse Avalanche Energy (Note 3)	37	mJ
$\begin{array}{lll} \mbox{Power Dissipation (Note 1a)} & T_A = 25^\circ C \\ \mbox{Power Dissipation (Note 1b)} & T_A = 25^\circ C \\ \end{array}$	2.4 0.9	W
Operating and Storage Junction Temperature Range	–55 to +150	°C
	Drain to Source VoltageGate to Source VoltageDrain Current - Continuous (Note 1a) - Pulsed (Note 4)Single Pulse Avalanche Energy (Note 3)Power Dissipation (Note 1a) Power Dissipation (Note 1b)T_A = 25°C Power Dissipation (Note 1b)T_A = 25°C COperating and Storage Junction	Drain to Source Voltage60Gate to Source Voltage ± 20 Drain Current - Continuous (Note 1a) $T_A = 25^{\circ}C$ Pulsed (Note 4) 45 Single Pulse Avalanche Energy (Note 3) 37 Power Dissipation (Note 1a) $T_A = 25^{\circ}C$ Power Dissipation (Note 1b) $T_A = 25^{\circ}C$ 0.90perating and Storage Junction

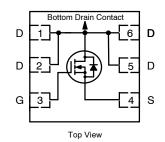
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

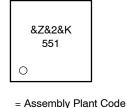
Symbol	Parameter	Ratings	Unit
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a)	52	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Note 1b)	145	



PIN CONNECTIONS



MARKING DIAGRAM



- = Data Code (Year & Week)
 - = Lot Run Code

&Z

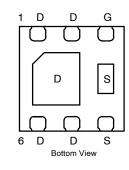
&2

&K

551

= Specific Device Code

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS $T_A = 25^{\circ}C$ unless otherwise noted.

Parameter	Test Conditions	Min	Тур	Max	Unit	
CTERISTICS			-	-		
Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	60	-	-	V	
Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	-	31	-	mV/°C	
Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V	-	-	1	μA	
Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	100	nA	
TERISTICS						
Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	1.0	1.8	3.0	V	
Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C	-	-5	-	mV/°C	
Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 7.5 A	-	19	23	mΩ	
	$V_{GS} = 4.5 \text{ V}, I_D = 6 \text{ A}$	-	26	35		
	V_{GS} = 10 V, I_{D} = 7.5 A, T_{J} = 125°C	1	28	33		
Forward Transconductance	V _{DD} = 5 V, I _D = 7.5 A	-	21	-	S	
IARACTERISTICS						
Input Capacitance	$V_{DS} = 30 V, V_{GS} = 0 V,$	-	881	1235	pF	
Output Capacitance	f = 1.0 MHz		182	255		
Reverse Transfer Capacitance		-	6.1	15		
Gate Resistance		0.1	0.5	1.5	Ω	
CHARACTERISTICS						
Turn–On Delay Time	$V_{DD} = 30 \text{ V}, \text{ I}_{D} = 7.5 \text{ A},$	-	7.3	15	ns	
Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	_	1.7	10		
Turn–Off Delay Time		-	16	29		
Fall Time		-	1.4	10		
Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V,$ $V_{DD} = 30 V, I_D = 7.5 A$	-	12	17	nC	
	$V_{GS} = 0 V \text{ to } 4.5 V,$ $V_{DD} = 30 V, I_D = 7.5 A$	-	5.8	8.1		
Gate to Source Charge	V _{DD} = 30 V, I _D = 7.5 A	-	2.7	3.8		
Gate to Drain "Miller" Charge		-	1.4	2.0	<u> </u>	
RCE DIODE CHARACTERISTICS						
	Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate to Source Leakage Current TERISTICS Gate to Source Threshold Voltage Gate to Source Threshold Voltage Temperature Coefficient Static Drain to Source On Resistance Forward Transconductance IARACTERISTICS Input Capacitance Output Capacitance Gate Resistance CHARACTERISTICS Input Capacitance Reverse Transfer Capacitance Gate Resistance CHARACTERISTICS Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	CTERISTICSDrain to Source Breakdown Voltage $I_D = 250 \ \mu$ A, $V_{GS} = 0 \ V$ Breakdown Voltage Temperature $I_D = 250 \ \mu$ A, Referenced to 25° CZero Gate Voltage Drain Current $V_{DS} = 48 \ V, V_{GS} = 0 \ V$ Gate to Source Leakage Current $V_{GS} = \pm 20 \ V, V_{DS} = 0 \ V$ TERISTICSGate to Source Threshold VoltageGate to Source Threshold Voltage $I_D = 250 \ \mu$ A, Referenced to 25° CGate to Source Threshold Voltage $I_D = 250 \ \mu$ A, Referenced to 25° CTemperature Coefficient $I_D = 250 \ \mu$ A, Referenced to 25° CStatic Drain to Source On Resistance $V_{GS} = 10 \ V, I_D = 7.5 \ A$ VGS = 10 \ V, I_D = 7.5 \ A, T_J = 125^{\circ}CForward TransconductanceVDD = 5 \ V, I_D = 6 \ A \ V_{GS} = 10 \ V, I_D = 7.5 \ A, T_J = 125^{\circ}CForward Transconductance $V_{DS} = 30 \ V, V_{GS} = 0 \ V, f = 1.0 \ MHz$ Input CapacitanceVDD = 5 \ V, I_D = 7.5 \ A, T_J = 125^{\circ}CMARACTERISTICSInput CapacitanceInput CapacitanceVDD = 30 \ V, I_D = 7.5 \ A, V_{GS} = 10 \ V, R_{GEN} = 6 \ \OmegaTurm-On Delay TimeVGS = 0 \ V to 10 \ V, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{GS} = 0 \ V to 10 \ V, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{GS} = 0 \ V to 10 \ V, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{GS} = 0 \ V to 10 \ V, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{GS} = 0 \ V to 10 \ V, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{GS} = 0 \ V to 10 \ V, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{GS} = 0 \ V to 10 \ V, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{GS} = 0 \ V to 10 \ V, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{DD} = 30 \ V, I_D = 7.5 \ A, V_{DD} =	$\begin{tabular}{ c c c c } \hline V_{DS} = 30 \ V, \ V_{GS} = 0 \ V & 60 \\ \hline Preakdown \ Voltage \ Temperature \ Coefficient & \ I_D = 250 \ \mu\text{A}, \ V_{GS} = 0 \ V & - \ Referenced to 25^\circ\text{C} & - \ Referenced to 25^\circ\text{C}$	$\begin{tabular}{ c c c c } \hline V_{CE} = 10 V_{CS} = 0 V_{CS} = 0$	$\begin{tabular}{ c c c c c } \hline $V_{DE} = $250 μA, $V_{GS} = 0$ V$ & 60 & - & - \\ \hline $Preakdown Voltage Temperature Coefficient $$I_D = $250 μA, $V_{GS} = 0$ V$ & - & - & 1 \\ \hline $I_D = $250 μA, $Prescript{Referenced to 25°C$ $$ $- & 31 & - \\ \hline $Referenced to 25°C$ $$ $- & $- & $- & $- & 1 \\ \hline $Coefficient $$ $V_{DS} = 48$ V, $V_{GS} = 0$ V$ & - & $- & $- & 1 \\ \hline $Caete to Source Leakage Current $$V_{GS} = $V_D, $V_{DS} = 0 V$ & $- & $- & $- & 1 \\ \hline $Caete to Source Threshold Voltage $$V_{GS} = $V_{DS}, $I_D = $250 μA $$ 1.0 $$ 1.8 $$ 3.0 \\ \hline $Caete to Source Threshold Voltage $$V_{GS} = $V_{DS}, $I_D = $250 μA $$ $$ 1.0 $$ 1.8 $$ 3.0 \\ \hline $Caete to Source Threshold Voltage $$V_{GS} = 10 V, $I_D = 7.5 $$ $$ $$ $- $$ $$ $- $$ $$ $- $$ $$ $- $$ $$$	

V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 2 A (Note 2)$	-	0.8	1.2	V
		V _{GS} = 0 V, I _S = 7.5 A (Note 2)		0.9	1.2	
t _{rr}	Reverse Recovery Time	I _F = 7.5 A, di/dt = 100 A/µs	-	23	37	ns
Q _{rr}	Reverse Recovery Charge		-	9.7	19	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

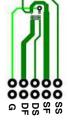
1. R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.



a. 52°C/W when mounted

on a 1 in² pad of 2 oz copper

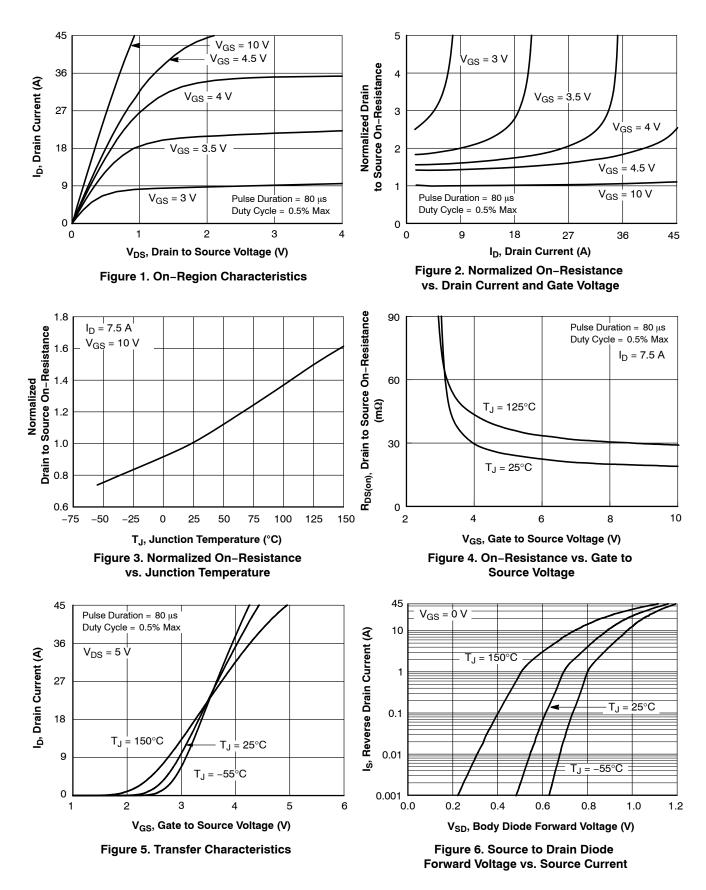




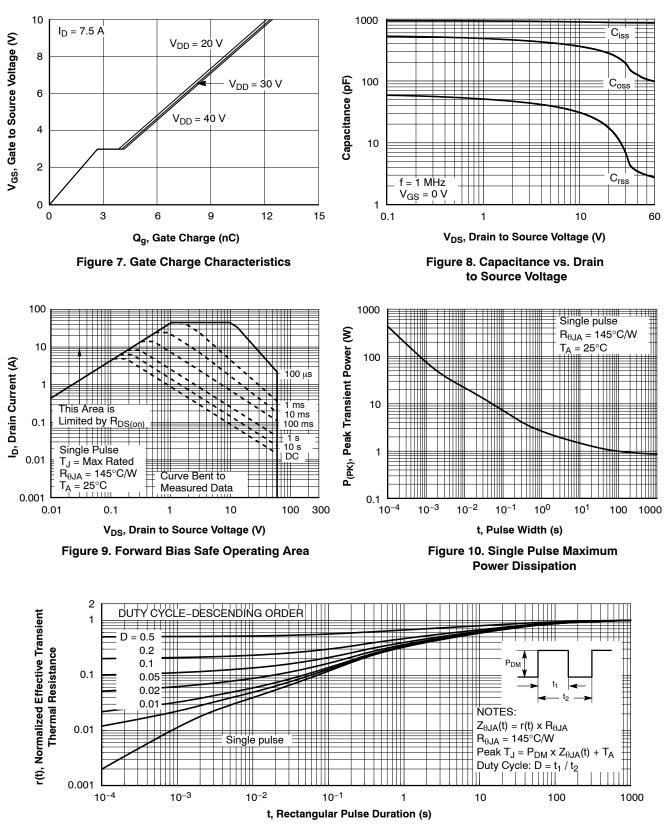
b. 145°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0% 3. E_{AS} of 37 mJ is based on starting T_J = 25°C, L = 3 mH, I_{AS} = 5 A, V_{DD} = 60 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 16 A. 4. Pulsed Id measured at td ≤ 250 μ s, refer to Figure 11 SOA graph for more details.

TYPICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)









ORDERING INFORMATION

Device	Device Marking	Package Type	Reel Size	Tape Width	Shipping [†]
FDMA86551L	551	WDFN6 2x2, 0.65P (Pb-Free/Halide Free)	7"	8 mm	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <u>BRD8011/D</u>.

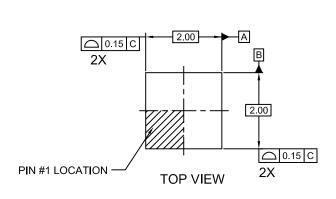
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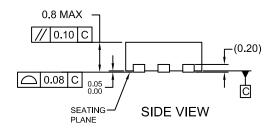
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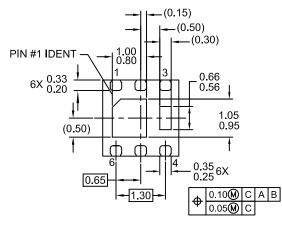


WDFN6 2x2, 0.65P CASE 511DB ISSUE O

DATE 31 AUG 2016





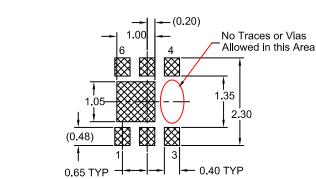


BOTTOM VIEW

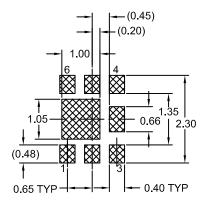
NOTES:

- A. DOES NOT FULLY CONFORM TO JEDEC REGISTRATION MO-229 DATED AUG/2003
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

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RECOMMENDED LAND PATTERN OPT 1



RECOMMENDED LAND PATTERN OPT 2

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